Search Notes



Applicati	on/Con	trol	No.

10/664,510 Examiner

Philip H. Leung

Applicant(s)/Patent under Reexamination

BEHNKE ET AL.

Art Unit

3742

	SEARCHED			
Class	Subclass	Date	Examiner	
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399	328-338			
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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(INCLUDING SEAR	CH STRATEGY	<u>')</u>
	DATE	EXMR
EAST searched Inventorship checked	7/9/2005	P.L.
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